Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/813,129	HIRAMATSU ET AL.	
Examiner	Art Unit	
Hiep Nguyen	2816	

SEARCHED					
Class	Subclass	Date	Examiner		
327	143	04.26.05	My		
	198 63 68	7	7		
	63				
	68				
	72 538				
	538				
	77	J .	J		
Uphaled Search		06.27.05	Mo		
Search	4				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	04.18.05	Ha	
EAST	05.12.05	Mar	